## Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination JANSSEN ET AL.

Examiner

Leonid Shapiro

Applicant(s)/Patent Under Reexamination JANSSEN ET AL.

Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,459,410	10-1995	Henley, Francois J.	324/770
	В	US-2002/0113766	08-2002	Keeney et al.	345/93
	С	US-6,028,442	02-2000	Lee et al.	324/770
	D	US-6,259,424	07-2001	Kurogane, Hideo	345/93
	Е	US-6,111,558	08-2000	Jeung et al.	345/93
	F	US-6,525,705	02-2003	Ishii et al.	345/87
	G	US-			
	Н	US-			
	1	US-			
	J	US-	-		
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	07-199866	08-1995	Japan	Haruhiko	
	0					
	Р					
	σ					
	R					
	S					
	Ţ					

## **NON-PATENT DOCUMENTS**

	NON-FATERI DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
: 	C							
	٧							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

